A utom atic physical phasing X -ray crystallography

Sergio L. Morelhao,¹, Luis H. Avanci,¹ and Stefan Kycia²

¹Instituto de F sica, Universidade de Sao Paulo, CP 66318, 05315-970 SaoPaulo, SP, Brazil ²Laboratorio Nacional de Luz S ncrotron/LNLS, CP 6192, 13084-971 Campinas, SP, Brazil

(Dated: April 14, 2024)

Phase invariants are important pieces of inform ation about the atom ic structures of crystals. There are several mathematical methods in X-ray crystallography to estimate phase invariants. The multi-wave diraction phenomenon o ers a unique opportunity of physically measuring phase invariants. In this work, the underneath principals for developing an automatic procedure to extract accurate phase-invariant values are described. A general systematic procedure is demonstrated, in practice, by analyzing intensity data from a KDP crystal.

PACS num bers: 61.10 N z; 61.10 D p K eywords: X -ray di raction, sem iconductors, nanom aterials

I. IN TRODUCTION

In X-ray crystallography, the phases of the di racted waves are roughly estim ated by mathematical methods, know as D irect M ethods^{1,2}, for analyzing intensity data sets composed of a large number of relations. These methods exploit algebraic or probabilistic relationships among the phase values. Some of such relationships are triplet phase invariants; they are invariant from the choice of origin in the crystal lattice. Experimental procedures allowing physical measurements of phase invariants are of great interest since, in principle, they could extend the e ciency of the D irect M ethods to complex structures such as proteins. It would have to be compared to other procedures that are actually used to the same purposes, such as multiple anomalous dispersion and multiple isom orphous replacement³.

Physical measurem ents of triplet phase invariants are possible by means of three-beam diraction (3BD) experiments4,5 where the interference of simultaneously di racted waves provide information on phase values. However, besides all experimental and analytical di culties involved in phase determination from 3BD experiments, the most serious and practical limitation of physical-phasing crystallography (PPC) is the reduce num ber of 3BD cases suitable for phasing. The reciprocal space of complex molecule crystals are full of re ections where isolated 3BD cases have become even more rare; phasing general n-beam cases (n > 3) is not feasible at the moment due to theoretical de ciencies. Therefore, it is in portant to m ention that, regarding com plex crystals, the usefulness of PPC is quite limited when compared to the available phasing procedures. Nevertheless, there are researches focused on developing and optim izing experimental data collection procedures for PPC⁶. On the other hand, the 3BD experiments o er an unique opportunity for accurate determ ination of triplet phase invariants, and consequently, for studying crystalline structures via m easurem ents of these invariants. For exam ple, depending on the achieved experim ental accuracy, electron density of chem ical bonding charges⁷ or even distortion of molecules under applied electric eld can be

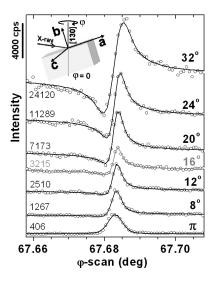


FIG.1: Experimental (open circles) and simulated (solid lines) '-scans of the 260=112=152 three-beam diraction in a KDP crystal taken at di erent polarization angle, (right-hand side of each scan). [001] is the reference direction (' = 0, see inset), X-ray photon energy is 7482eV, and further experimental details can be found elsewhere⁸. The intensity scale is linear, but for visualization purposes the ordinates of some scans are shifted from their actual values, given at the left (in cps). The '-scan at = 16 (gray scan) was mistakenly collected at the shoulder of the 260 re ection (! = 0.003, 30% of the FW HM = 0.01). The exibility of the tting equation, Eq. (1), to reproduce these '-scans is exploited in Fig. 3 (b).

investigated by monitoring a few triplet phases. Note that each triplet phase is an absolute value since it already is the phase di erences between two di racted X - ray waves, and not a relative quantity such as obtained in peak position or intensity measurements.

This work has been motivated by our desired of developing at LNLS a system atic and practical procedure for determ ining phase invariants with good accuracy. Experim entaland analytical procedures are still to be im proved to push phase measurem ents from the state-of-art to routinely and autom atic phasing procedures; otherwise it will be very di cult to non-expert users to take advantages of the new possibilities o ered by measuring this physical quantity. D ata collection procedures are already proposed⁴, and undergoing im provem ent⁸, but the actual challenger is the data analysis procedure⁵. Here, we outline the undermeath principals for developing an autom atic procedure to extract accurate phase values from 3BD interference pro les. A general system atic procedure is dem onstrated, in practice, by analyzing 3BD intensity data from a KDP crystal, and the major sources of errors are pointed out.

II. THEORETICAL BASIS

In general, the 3BD intensity pro les are dominated by the interference of two di racted waves. It leads to a relatively simple parametric equation that can be used to t most of the experimental intensity pro les and to extract the phase values. It is given by⁵

$$I(') = (1 \quad bf(u)f) \quad D_{A}f + D_{BC}(u)f + D_{A} \quad D_{BC}(u) + D_{A} \quad D_{BC}(u) \quad G(' \quad u)du$$
(1)

where $D_A = D_0 v_A$ and D_{BC} (') = $D_0 R f$ (') $e^{i_T} v_{BC}$ are the amplitudes of the primary and secondary electric displacement wave elds generated by the primary re ection, A, and by the detour re ection (also known as Umwegre ection) formed by two consecutive re ections, B and C.R stands form axim um am plitude ratio of these waves. v_A and v_{BC} are polarization factors for linearly polarized incident radiation. $_{\rm T}\,$ is the phase di erence between these waves, which is the triplet phase invariant. A gaussian convolution, G(u) with FW HM = w_G and $u_0 = 2.5 w_G$, is necessary to account for the instrum ental width $w_{G} \cdot f(') = w_{S} = [2(' '_{0}) iw_{S}]$ is a line pro le function (FW HM = w, $w_{\rm S}$ = w) describing the intrinsic 3BD pro le as a function of the azim uthal rotation angle '. b and are related to energy balance m echanism s am ong the di racted beam s and crystalline im perfections, respectively⁵.

E sentially, the analytical problem in accurate phase determ ination resides on how to adjust the vector of parameters, $p = [w;R; ;b;'_0;w_G]$, without compromising the extracted values for $_T$. Here, a simple and fast evolutionary algorithm (DEA)⁹ has been used for tting the experimental proles where the improvements of the t-tings are guided by a mean-absolute deviation function, E (p). The basic strategy is then to nd out the minimum of E (p) as a function of $_T$, i.e. $E_0(_T)$, while p is kept within reasonable ranges of allowed values. The minimum of the $E_0(_T)$ curve, $@E_0=@_T = 0$, provide the experimental value for $_T$.

III. RESULTS AND DISCUSSIONS

Fig.1 shows set of 3BD data collected at B razilian Synchrotron Light Laboratory (LNLS) with the polarim eterlike di ractom eter described elsewhere⁸. It is composed of several '-scans taken at di erent polarization angles , as indicated in Fig.1. Instrumental broadening e ects on the interference proles, as illustratively shown in Fig. 2(a), can reduce accuracy when combined with the uncertainty of the R parameter, which is in fact the major source of inaccuracy, as demonstrated in Fig. 2(b). The $E_0(_T)$ curves in Fig. 2(b) is just showing that it is not possible to extract an accurate value of $E_0(_T)$ from a single '-scan when R is unknown.

The best strategy, that we could elaborate, for accurate determination of triplet phases is composing polarization-dependent sets of azin uthal scans, as the one in Fig. 1, and then, search for the value of R that provides $@E_0=@_T = 0$ as close as possible of a same $_T$ value. Here this search strategy has been applied in two sets of azim uthal scans: a simulated one that is free of instrum entale ects such as statistic noise and sam ple m isalignments, and another that is the experimental data in Fig. 1. The E₀($_T$) curves of the simulated '-scans for several values of R are shown in Fig. 3 (a) while Fig. 3 (b) show s the respective E₀($_T$) curves for the experimental data.

IV. CONCLUSIONS

The data analyses presented here have dem onstrated that system atic and reliable phasing procedures are feasible. However, accuracy can be improved by optimizing the incident X-ray beam optics regarding energy resolution and angular divergences, mainly in the horizontal plane. A good instrum ental precision is also required as well as low noise in the intensity data.

A cknow ledgm ents

This work has been supported by the Brazilian Synchrotron Light Source (LNLS) under proposalNo.D12A

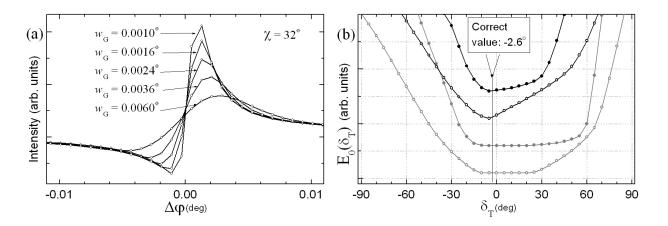


FIG. 2: (a) Simulated instrum ental broadening e ects on '-scans. Simulation parameters used into Eq. (1): $_{\rm T}$ = 2:6, = 32, and p = [0:0012; 1:0; 0:8; 0:0; 67:683; w_G] where the instrum ental width values, w_G, are indicated by arrows. ' = ' ' 0. (b) Theoretical accuracy in phase measurements as a function of the instrum ental width w_G, and am plitude ratio R. The E₀(T) curves were obtained by tting the proles in (a) with w_G = 0:001 (open circles) and w_G = 0:006 (closed circles). The ttings have been carried out by the DEA within the allowed ranges: p = [0:0008 : 0:0012; R; 0:2 : 1:0; 0:0; '0 0:012; 0:001 : 0:007] where R = 1:0 (black lines) or R = [0:6:1:4] (gray lines). De nition on the @E₀=@_T = 0 position gives the accuracy on T.

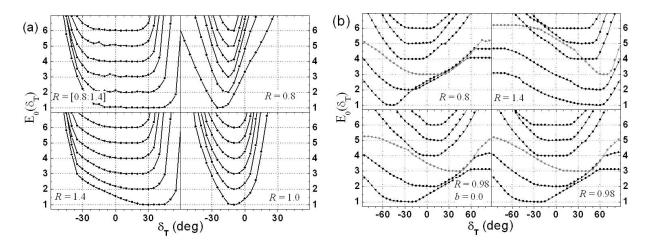


FIG.3: Absolute mean deviation as a function of $_{T}$, E_{0} ($_{T}$), obtained for (a) the simulated scans and (b) the experimental scans in Fig.1. All curves are normalized by its minimum value and add to an integer for better visualization. The curves with minim a equal to 1, 2, 3, 4, 5, and 6 correspond to those scans with = 8, 12, 16, 20, 24, and 32, respectively. A llow ed range is $p = [0.0010 : 0.0014; R; 0.0:10; 0.0:3v^2; '_{0} 0.012; 0.001 : 0.006]$ where the R values or ranges are shown in the gure for each case, and v^2 changes the upper limit of the brange with the polarization angle; here $v^2 = \sin^2$.

-XRD1-1264, FAPESP (proc. No. 02/10387-5), and

CNPq (proc. No. 301617/95-3 and 150144/03-2).

E lectronic address: m orelhao@ if.usp br

- ¹ K.Banerjee, Phys.Teach.2, 5 (1960)
- ² H A. Hauptmann and J. Karle, Nobel Lectures in Chemistry, Singapoure: W ord Scientic (1992)
- ³ J.R. Helliwell, J. Synchrotron Rad. 9, 1 (2002)
- ⁴ S.L.M orelhao and S.K ycia, Phys. Rev. Lett. 89 (1), 015501 (2002)
- ⁵ S.L.M orelhao, A cta C ryst. A 59, 470 (2003)

- ⁶ Q.Shen, S.K ycia, and I.D obrianov, A cta C ryst. A 56, 268 (2000)
- ⁷ S.L.M orelhao, L.H. A vanci, and S.K ycia in Study of crystalline structures by physical determ ination of triplet phase invariants, presented at the SRM S-4, G renoble, A ugust 23-25, 2004.
- ⁸ S.L.M orelhao, J. Synchrotron Rad. 10, 236 (2003)
- ⁹ M. W orm ington et. al, Phil. Trans. R. Soc. Lond. A 357, 2827 (1999)